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# AO4468

# 30V N-Channel MOSFET

# **General Description**

The AO4468 combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{\text{DS}(\text{ON})}.$  This device is ideal for load switch and battery protection applications.

\* RoHS and Halogen-Free Compliant

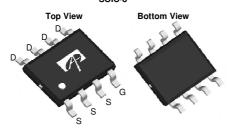
# **Product Summary**

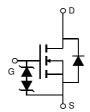
 $\begin{array}{ll} V_{DS} & 30V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 10.5A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 17m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 4.5V) & < 23m\Omega \end{array}$ 

ESD Protected 100% UIS Tested 100% R<sub>g</sub> Tested



#### SOIC-8





#### Absolute Maximum Ratings T<sub>A</sub>=25℃ unless otherwise noted

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V <sub>DS</sub>	30	V	
Gate-Source Voltage		$V_{GS}$	±20	V	
Continuous Drain Current	T <sub>A</sub> =25℃		10.5		
	T <sub>A</sub> =70℃	'D	8.5	A	
Pulsed Drain Current <sup>C</sup>		I <sub>DM</sub>	50		
Avalanche Current <sup>C</sup>		I <sub>AS</sub> , I <sub>AR</sub>	19	A	
Avalanche energy L=0.1mH <sup>C</sup>		E <sub>AS</sub> , E <sub>AR</sub>	18	mJ	
	T <sub>A</sub> =25℃		3.1	w	
Power Dissipation <sup>B</sup>	T <sub>A</sub> =70℃		2		
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	C	

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	31	40	℃/W			
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	59	75	℃/W			
Maximum Junction-to-Lead Steady-S		$R_{\theta JL}$	16	24	℃/W			



#### Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units				
STATIC PARAMETERS										
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D=250\mu A,\ V_{GS}=0V$	30			V				
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V			1	μΑ				
		T <sub>J</sub> =55℃			5					
I <sub>GSS</sub>	Gate-Body leakage current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±16V			±10	μA				
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_{D}=250\mu A$	1.2	1.8	2.4	V				
$I_{D(ON)}$	On state drain current	$V_{GS}=10V$ , $V_{DS}=5V$	50			Α				
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =10.5A		14	17	mΩ				
		T <sub>J</sub> =125℃		20	24					
		$V_{GS}$ =4.5V, $I_D$ =9A		18	23	mΩ				
<b>g</b> FS	Forward Transconductance	$V_{DS}=5V, I_{D}=10.5A$		36		S				
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V		0.75	1	V				
$I_S$	Maximum Body-Diode Continuous Curr			4	Α					
DYNAMIC	PARAMETERS									
$C_{iss}$	Input Capacitance			740	888	pF				
C <sub>oss</sub>	Output Capacitance	$V_{GS}$ =0V, $V_{DS}$ =15V, f=1MHz		110	145	pF				
$C_{rss}$	Reverse Transfer Capacitance			82	115	рF				
$R_g$	Gate resistance	$V_{GS}=0V$ , $V_{DS}=0V$ , $f=1MHz$	0.5	1.1	1.7	Ω				
SWITCHI	NG PARAMETERS									
Q <sub>g</sub> (10V)	Total Gate Charge			15		nC				
Q <sub>g</sub> (4.5V)	Total Gate Charge	V 10V V 15V L 10 5A		7.5		nC				
$Q_{gs}$	Gate Source Charge	$V_{GS}$ =10V, $V_{DS}$ =15V, $I_{D}$ =10.5A		2.5		nC				
$Q_{gd}$	Gate Drain Charge	1		3		nC				
$t_{D(on)}$	Turn-On DelayTime			5		ns				
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =15V, $R_L$ =1.45 $\Omega$ ,		3.5		ns				
$t_{D(off)}$	Turn-Off DelayTime	$R_{GEN}=3\Omega$		19		ns				
t <sub>f</sub>	Turn-Off Fall Time			3.5		ns				
t <sub>rr</sub>	Body Diode Reverse Recovery Time	$I_F$ =10.5A, dI/dt=100A/ $\mu$ s		18	22	ns				
$Q_{rr}$	Body Diode Reverse Recovery Charge	$I_F$ =10.5A, dI/dt=100A/ $\mu$ s		9	12	nC				

A. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25° C. The value in any given application depends on the user's specific board design. B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^\circ$  C, using  $\leqslant$  10s junction-to-ambient thermal resistance. C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}=150^\circ$  C. Ratings are based on low frequency and duty cycles to keep

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D. The  $R_{\theta JA}$  is the sum of the thermal impedence from junction to lead  $R_{\theta JL}$  and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

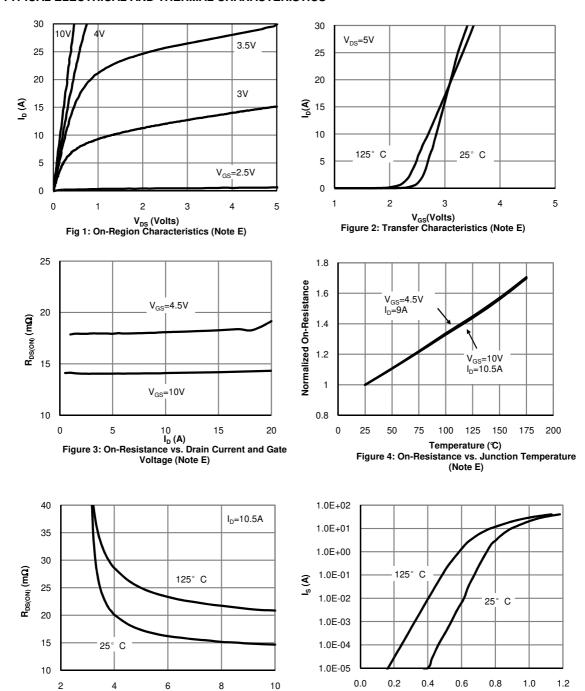
F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

V<sub>GS</sub> (Volts) Figure 5: On-Resistance vs. Gate-Source Voltage

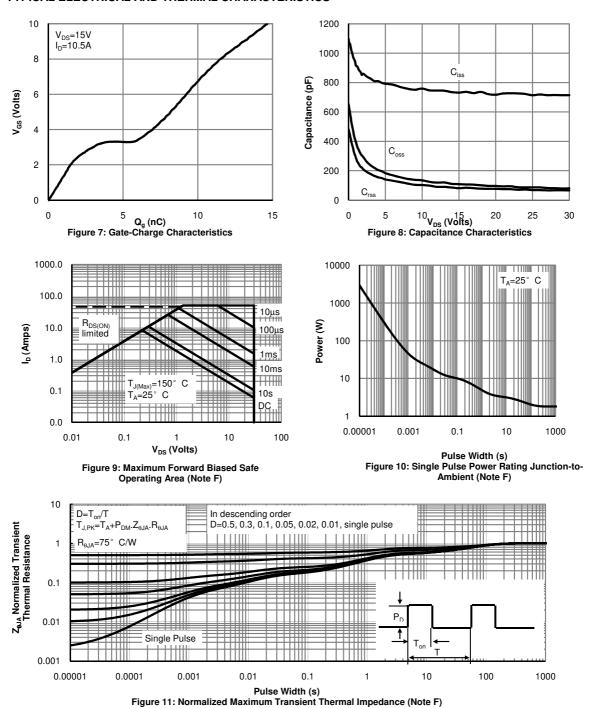
(Note E)



V<sub>SD</sub> (Volts) Figure 6: Body-Diode Characteristics (Note E)



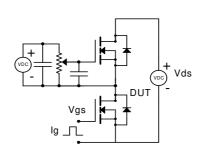
#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

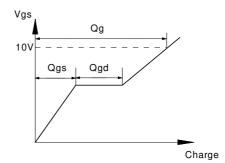


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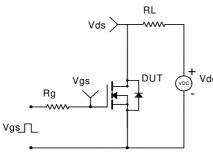


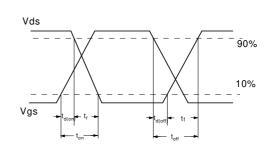
# Gate Charge Test Circuit & Waveform



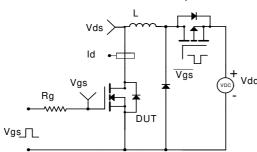


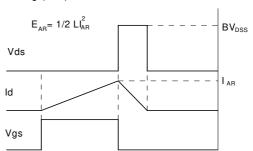
Resistive Switching Test Circuit & Waveforms





# Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





# Diode Recovery Test Circuit & Waveforms

